



## Notice of References Cited

Application/Control No.
09/492,728
Examiner

Applicant(s)/Patent Under Reexamination NADEN, REX A

Art Unit 2614

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

BRIAN P. YENKE

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0163578	11-2002	Adair et al.	348/158
	В	US-5,767,897	06-1998	Howell, Brian A.	348/14.07
	С	US-2002/0018117	02-2002	Tosaya, Carol	348/14.08
	D	US-6,574,674	06-2003	May et al.	719/310
	Е	US-5,990,932	11-1999	Bee et al.	348/14.08
	F	US-5,818,616	10-1998	Kawai, Hisashi	398/72
	G	US-5,657,246	08-1997	Hogan et al.	348/14.1
	Н	US-5,397,133	03-1995	Penzias, Arno A.	463/22
	1	US-5,025,314	06-1991	Tang et al.	348/14.08
	J	US-6,657,654	12-2003	Narayanaswami, Chandrasekhar	348/14.04
	К	US-6,434,403	08-2002	Ausems et al.	455/556.2
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	α					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	J	
	>	
	W	
	x	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.